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Corrigendum

Corrigendum to ‘Soft X-ray detection and photon counting spectroscopy with commercial 4H-SiC Schottky photodiodes’ [Nucl. Instrum. Methods Phys. Res. A 830 (2016) 1–5]



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The authors have been informed by the manufacturer of the photodiodes (SGLux SolGel Technologies GmbH, Berlin, Germany) that the photodiodes reported had Ohmic contacts rather than Schottky contacts.

The authors apologize for any inconvenience caused.

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